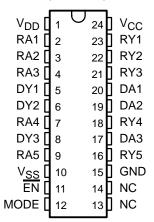
LOW-POWER MULTIPLE RS-232 DRIVERS/RECEIVERS

SLLS256F - DECEMBER 1996 - REVISED NOVEMBER 2001

- Single-Chip RS-232 Interface for IBM™ **PC-Compatible Serial Port**
- Designed to Transmit and Receive 4-µs Pulses (Equivalent to 256 kbit/s)
- Standby Power Is Less Than 750 µW Maximum
- Wide Supply-Voltage Range . . . 4.75 V to 15 V
- **Driver Output Slew Rates Are Internally** Controlled to 30 V/µs Maximum
- **RS-232 Bus-Pin ESD Protection Exceeds:** - 15 kV, Human-Body Model
- Receiver Input Hysteresis . . . 1000 mV Typical
- Three Drivers and Five Receivers Meet or Exceed the Requirements of TIA/EIA-232-F and ITU v.28 Standards
- Complements the SN75LP196
- One Receiver Remains Active During WAKE-UP Mode (100 μA Maximum)
- **Matches Flow-Through Pinout of** Industry-Standard SN75185, SN75C185, and **SN75LP185, With Additional Control Pins**
- **Package Options Include Plastic Shrink** Small-Outline (DB), Small-Outline (DW), and Thin Shrink Small-Outline (PW) Packages, and Standard Plastic (NT) DIPs

DB, DW, NT, OR PW PACKAGE (TOP VIEW)



NC - No internal connection

description

The SN75LPE185 is a low-power bipolar device containing three drivers and five receivers, with 15-kV ESD protection on the bus pins, with respect to each other. Bus pins are defined as those pins that tie directly to the serial-port connector, including GND. The pinout matches the flow-through design of the industry-standard SN75185, SN75C185, and SN75LP185, with the addition of four pins for control signals. The flow-through pinout of the device allows easy interconnection of the universal asynchronous receiver/transmitter (UART) and serial-port connector of the IBM™ PC compatibles. The SN75LPE185 provides a rugged, low-cost solution for this function, with the combination of bipolar processing and 15-kV ESD protection.

The SN75LPE185 has an internal slew-rate control to provide a maximum rate of change in the output signal of 30 V/ μ s. The driver output swing is clamped at ± 6 V to enable the higher data rates associated with this device and to reduce EMI emissions. Although the driver outputs are clamped, the outputs can handle voltages up to ±15 V without damage.



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description (continued)

The device has flexible control options for power management when the serial port is inactive. A common disable for all of the drivers and receivers is provided with the active-low enable (\overline{EN}) input. The mode-control (MODE) input selects between the STANDBY and WAKE-UP modes. With a low-level input on MODE and a high-level input on \overline{EN} , one receiver remains active, while the remaining drivers and receivers are disabled to implement the WAKE-UP mode. With a high-level input on both MODE and \overline{EN} , all drivers and receivers are disabled to implement the STANDBY mode. The outputs of the drivers are in the high-impedance state when the device is powered off. To ensure the outputs of the receivers are in a known output level (as listed in the Application Information section of this data sheet) when the device is powered off, in STANDBY mode, or in WAKE-UP mode, external pullup/pulldown circuitry must be provided. All the logic inputs accept 3.3-V or 5-V input signals.

The SN75LPE185 complies with the requirements of TIA/EIA-232-F and ITU v.28 standards. These standards are for data interchange between a host computer and peripheral at signaling rates up to 20 kbit/s. The switching speeds of the SN75LPE185 support rates up to 256 kbit/s.

The SN75LPE185 is characterized for operation from 0°C to 70°C.

AVAILABLE OPTIONS

Γ			PACKAGE	DEVICES	
	T _A	PLASTIC SHRINK SMALL OUTLINE (DB)	PLASTIC SMALL OUTLINE (DW)	PLASTIC THIN SHRINK SMALL OUTLINE (PW)	PLASTIC DIP (NT)
	0°C to 70°C	SN75LPE185DBR	SN75LPE185DW	SN75LPE185PWR	SN75LPE185NT

The DB and PW packages are only available taped and reeled. The DW package is also available taped and reeled. Add the suffix R to device type (e.g., SN75LPE185DWR).

Function Tables

DRIVERS

INPUT DA	ENABLE EN	OUTPUT DY
Х	Н	Z
Н	L	L
L	L	Н
Open	L	L
н	Open	L
L	Open	Н

H = high level, L = low level,

X = irrelevant, Z = high impedance (off)



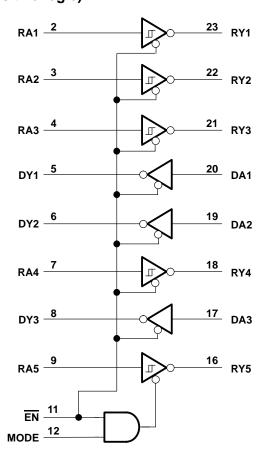
Function Tables (Continued)

RECEIVERS

INPUT	s:		BLE UTS	OUTPU	тѕ
RA1-RA4	RA5	EN	MODE	RY1-RY4	RY5
Н	Н	L	Х	L	L
L	L	L	Χ	Н	Н
Х	Н	Н	L	Z	L
Х	L	Н	L	Z	Н
Х	X	Н	Н	z z	
Open	Open	L	Χ	Н	н
Н	Н	L	Open	L	L
L	L	L	Open	Н	Н
Х	Н	Н	Open	Z	L
Х	L	Н	Open	Z	н
Н	Н	Open	Χ	L L	
L	L	Open	Χ	Н	Н

H = high level, L = low level, X = irrelevant, Z = high impedance (off)

functional logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Positive supply voltage range: V _{CC} (see Note 1)	–0.5 V to 7 V
V _{DD} (see Note 1)	
Negative supply voltage range, V _{SS} (see Note 1)	
Receiver input voltage range, V _I (RA)	–30 V to 30 V
Driver input voltage range, V _I (DA, EN , MODE)	\cdot . -0.5 V to V _{CC} + 0.4 V
Receiver output voltage range, V _O (RY)	–0.5 V to 6 V
Driver output voltage range, V _O (DY)	–15 V to 15 V
Electrostatic discharge, bus pins: Human-body model (see Note 2)	Class 3: 15 kV
Machine model (see Note 2)	Class 3: 500 V
Electrostatic discharge, all pins: Human-body model (see Note 2)	Class 3: 5 kV
Machine model (see Note 2)	Class 3: 200 V
Package thermal impedance, θ_{JA} (see Note 3): DB package	63°C/W
(see Note 3): DW package	46°C/W
(see Note 4): NT package	67°C/W
(see Note 3): PW package	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to network ground terminal unless otherwise noted.

- 2. Per MIL-STD-883 Method 3015.7
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.
- 4. The package thermal impedance is calculated in accordance with JESD 51-3.

recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	Supply voltage (see Note 5)		4.75	5	5.25	V
V_{DD}	Supply voltage		9	12	15	V
Vss	Supply voltage		-9	-12	-15	V
V_{IH}	5 1 5	DA, EN, MODE	2			V
V_{IL}	Low-level input voltage	DA, EN, MODE			0.8	V
٧ _I	Receiver input voltage range	RA	-25		25	V
ЮН	High-level output current	RY			-1	mA
loL	Low-level output current	RY			2	mA
TA	Operating free-air temperature		0		70	°C

NOTE 5: VCC cannot be greater than VDD.



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supply currents over the recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
		No load,	$V_{DD} = 9 \text{ V}, V_{SS} = -9 \text{ V}, \overline{EN} \text{ at GND},$ See Note 6			1000	
Icc	Supply current for V _{CC}	All inputs at	$V_{DD} = 12 \text{ V}, V_{SS} = -12 \text{ V}, \overline{EN} \text{ at GND}$			1000	μΑ
		minimum V _{OH} or maximum V _{OL}	EN, MODE at V _{CC}			650	
			EN at V _{CC} , MODE at GND			700	
	No load, All inputs at	$V_{DD} = 9 \text{ V}, V_{SS} = -9 \text{ V}, \overline{EN} \text{ at GND},$ See Note 6				800	
I _{DD}			$V_{DD} = 12 \text{ V}, V_{SS} = -12 \text{ V}, \overline{EN} \text{ at GND}$			800	μΑ
		minimum V _{OH} or maximum V _{OL}	EN, MODE at V _{CC}			20	
			EN at V _{CC} , MODE at GND			20	
		No load,	$V_{DD} = 9 \text{ V}, V_{SS} = -9 \text{ V}, \overline{EN} \text{ at GND},$ See Note 6			-625	
ISS	Supply current for VSS	All inputs at minimum VOH	$V_{DD} = 12 \text{ V}, V_{SS} = -12 \text{ V}, \overline{EN} \text{ at GND}$	-625		-625	μΑ
		or maximum VOI	EN, MODE at V _{CC}	-50 -50			
			EN at V _{CC} , MODE at GND				

NOTE 6: Minimum RS-232 driver output voltages are not attained with ±5-V supplies.

driver electrical characteristics over the recommended operating conditions (unless otherwise noted)

	PARAMETER	TES	ST CONDITIONS	MIN	TYP	MAX	UNIT
\/-··	High-level output voltage	$V_{I} = 0.8 \text{ V}, R_{L} = 3 \text{ k}\Omega,$	$V_{DD} = 9 \text{ V}, V_{SS} = -9 \text{ V}, \overline{EN} \text{ at GND},$ See Note 6	5	5.8	6.6	V
VOH		See Figure 1	<u>VD</u> D = 12 V, VSS = −12 V, EN at GND, See Note 7	5	5.8	6.6	V
	Low-level	V _I = 2 V, R _L = 3 K,	V _{DD} = 9 V, V _{SS} = -9 V, EN at GND, See Note 6	- 5	-5.8	-6.9	V
VOL	output voltage	See Figure 1	<u>VD</u> D = 12 V, VSS = −12 V, EN at GND, See Note 7	- 5	-5.8	-6.9	V
lΉ	High-level input current	V _I at V _{CC}				1	μΑ
Ι _{ΙL}	Low-level input current	V _I at GND				-1	μΑ
loz	High-impedance output current	V _{CC} = 5 V, V _{DD} = 12 V, V	SS = -12 V, -5 V ≤ V _O ≤ 5 V			±100	μА
IOS(H)	Short-circuit high-level output current	$V_O = GND \text{ or } V_{SS},$	See Figure 2 and Note 8		-30	– 55	mA
I _{OS(L)}	Short-circuit low-level output current	$V_O = GND \text{ or } V_{SS},$	See Figure 2 and Note 8		30	55	mA
r _O	Output resistance	$V_{DD} = V_{SS} = V_{CC} = 0$,	V _O = 2 V	300			Ω

NOTES: 6. Minimum RS-232 driver output voltages are not attained with ±5-V supplies.



^{7.} Maximum output swing is limited to ±5.5 V to enable the higher data rates associated with this device and to reduce EMI emissions.

^{8.} Not more than one output should be shorted at one time.

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driver switching characteristics over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TES	TEST CONDITIONS MIN TYP MAX		UNIT		
^t PHL	Propagation delay time, high- to low-level output	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$	C _L = 15 pF, See Figure 1	300	800	1600	ns
tPLH	Propagation delay time, low- to high-level output	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$	C _L = 15 pF, See Figure 1	300	800	1600	ns
tPZL	Driver output-enable time to low-level output	R_L = 3 kΩ to 7 kΩ, C_L = 15 pF	STANDBY or WAKE-UP modes, See Figures 1 and 6 and Note 7		50	100	μs
tPZH	Driver output-enable time to high-level output	R_L = 3 kΩ to 7 kΩ, C_L = 15 pF	STANDBY or WAKE-UP modes, See Figures 1 and 6 and Note 7		50	100	μs
tPLZ	Driver output-disable time from low-level output	R_L = 3 kΩ to 7 kΩ, C_L = 15 pF	STANDBY or WAKE-UP modes, See Figures 1 and 6 and Note 7		50	100	μs
tPHZ	Driver output-disable time from high-level output	R_L = 3 kΩ to 7 kΩ, C_L = 15 pF	STANDBY or WAKE-UP modes, See Figures 1 and 6 and Note 7		50	100	μs
			Using 10%-to-90% transition region, Driver speed = 250 kbit/s, C _L = 15 pF	375		2240	
	Transition time, low- to high-level output	V _{CC} = 5 V, V _{DD} = 12 V, V _{SS} = -12 V,	Using ±3-V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	200		1500	
[†] TLH		$R_L = 3 k\Omega$ to 7 kΩ, See Figure 1 and Note 7	Using ±2-V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	133	1000		ns
			Using ±3-V transition region, Driver speed = 125 kbit/s, C _L = 2500 pF	2750		2750	
			Using 10%-to-90% transition region, Driver speed = 250 kbit/s, C _L = 15 pF	375		2240	
	Transition time,	V _{CC} = 5 V, V _{DD} = 12 V,	Using ±3-V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	200		1500	
^t THL	high- to low-level output	$\begin{aligned} &\text{VSS} = -12 \text{ V}, \\ &\text{R}_L = 3 \text{ k}\Omega \text{ to 7 k}\Omega, \\ &\text{See Figure 1 and Note 7} \end{aligned}$	Using ±2-V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	133		1000	ns
			Using ±3-V transition region, Driver speed = 125 kbit/s, C _L = 2500 pF			2750	
SR	Output slew rate	V_{CC} = 5 V, V_{DD} = 12 V, V_{SS} = -12 V, R_{L} = 3 kΩ to 7 kΩ, C_{L} = 15 pF, See Note 7	Using ±3-V transition region, Driver speed = 0 to 250 kbit/s	4	20	30	V/μs

NOTE 7: Maximum output swing is limited to ±5.5 V to enable the higher data rates associated with this device and to reduce EMI emissions.



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receiver electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

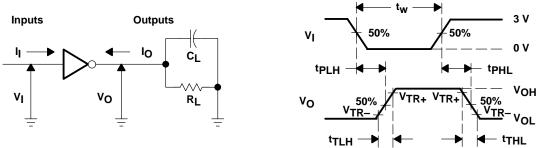
	PARAMETER	TEST	CONDITIONS	MIN	TYP	MAX	UNIT
V _{IT+}	Positive-going input threshold voltage	See Figure 3		1.6	2	2.55	V
V _{IT} –	Negative-going input threshold voltage	See Figure 3		0.6	1	1.45	V
V _{HYS}	Input hysteresis, V _{IT+} – V _{IT-}	See Figure 3		600	1100		mV
Vон	High-level output voltage	$I_{OH} = -1 \text{ mA}$		2.5	3.9		V
VOL	Low-level output voltage	$I_{OL} = 2 \text{ mA}$			0.33	0.5	V
1	High-level input current	V _I = 3 V		0.43	0.6	1	mΑ
lιΗ	nign-iever input current	V _I = 25 V	3.6	5.1	8.3	IIIA	
1	Low-level input current	V _I = −3 V		-0.43	-0.6	-1	mA
l IIL	Low-level input current	V _I = -25 V		-3.6	-5.1	-8.3	IIIA
IOS(H)	Short-circuit high-level output current	$V_{O} = 0,$	See Figure 5 and Note 8			-20	mA
los(L)	Short-circuit low-level output current	$V_O = V_{CC}$	See Figure 5 and Note 8			20	mA
loz	High-impedance output current	V _{CC} = 0 or 5 V,	$0.3~V \leq V_O \leq V_{CC}$			±100	μΑ
R _{IN}	Input resistance	$V_I = \pm 3 \text{ V to } \pm 25 \text{ V}$		3	5	7	kΩ

NOTE 8: Not more than one output should be shorted at one time.

receiver switching characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
^t PHL	Propagation delay time, high- to low-level output		400	900	ns
^t PLH	Propagation delay time, low- to high-level output		400	900	ns
tTLH	Transition time low- to high-level output		200	500	ns
^t THL	Transition time high- to low-level output		200	400	ns
tSK(P)	Pulse skew tpLH - tpHL	STANDBY mode	200	425	ns
tPZL	Receiver output-enable time to low-level output	$C_L = 50 \text{ pF},$	50	100	μs
tPZH	Receiver output-enable time to high-level output	See Figures 4 and 7	50	100	μs
^t PLZ	Receiver output-disable time from low-level output		50	100	μs
^t PHZ	Receiver output-disable time from high-level output		50	100	μs
tPHL	Propagation delay time, high- to low-level output (WAKE-UP mode)]	500	1500	ns
tPLH	Propagation delay time, low- to high-level output (WAKE-UP mode)		500	1500	ns

PARAMETER MEASUREMENT INFORMATION



NOTES: A. The pulse generator has the following characteristics: For $C_L < 1000$ pF: $t_W = 4 \mu s$, PRR = 250 kbit/s, $Z_O = 50 \Omega$, $t_f = t_f < 50$ ns. For C_L = 2500 pF: t_W = 8 μ s, PRR = 125 kbit/s, Z_O = 50 Ω , t_r = t_f < 50 ns.

B. C_L includes probe and jig capacitance.

Figure 1. Driver Parameter Test Circuit and Waveform

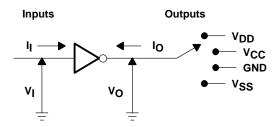


Figure 2. Driver IOS Test

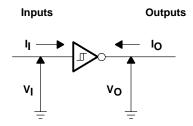
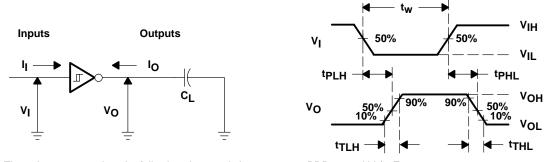


Figure 3. Receiver VIT Test



NOTES: A. The pulse generator has the following characteristics: $t_W = 4 \mu s$, PRR = 250 kbit/s, $Z_O = 50 \Omega$, $t_T = t_f < 50 ns$.

B. C_L includes probe and jig capacitance.

Figure 4. Receiver Parameter Test Circuit and Waveform



PARAMETER MEASUREMENT INFORMATION

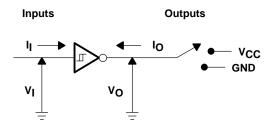
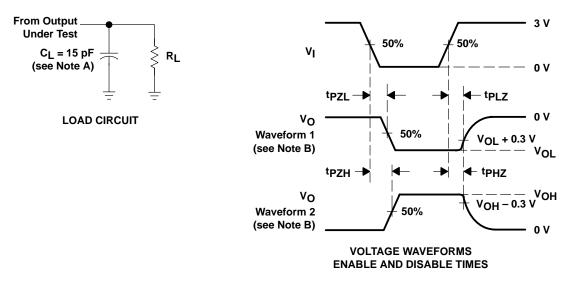


Figure 5. Receiver IOS Test



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR = 250 kbit/s, $Z_O = 50 \Omega$, $t_r = t_f < 50 \text{ ns}$.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 6. Driver 3-State Parameter Load Circuit and Voltage Waveforms

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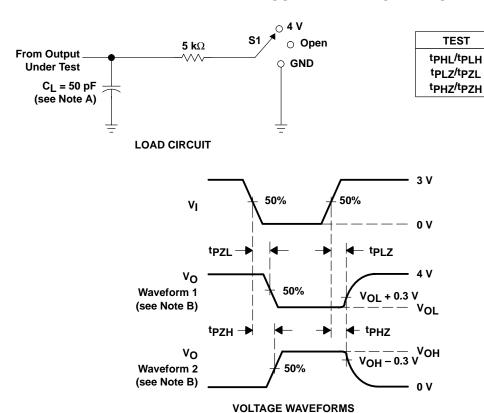
PARAMETER MEASUREMENT INFORMATION

S1

Open

4 V

GND



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR = 250 kbit/s, $Z_O = 50 \Omega$, $t_f = t_f < 50 \text{ ns}$.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 7. Receiver 3-State Parameter Load Circuit and Voltage Waveforms

ENABLE AND DISABLE TIMES



APPLICATION INFORMATION

receiver output states

RECEIVER KNOWN OUTPUT STATES DURING POWER-DOWN, STANDBY, OR WAKE-UP MODES									
RECEIVER NUMBER SIGNAL NAME RECEIVER OUTPUT									
RY1	DCD	High							
RY2	DSR	High							
RY3	RX	Low							
RY4	CTS	High							
RY5	RI	High							

fault protection during power down

Diodes placed in series with the V_{DD} and V_{SS} leads protect the SN75LPE185 in the fault condition, in which the device outputs are shorted to ± 15 V and the power supplies are at low voltage and provide low-impedance paths to ground.

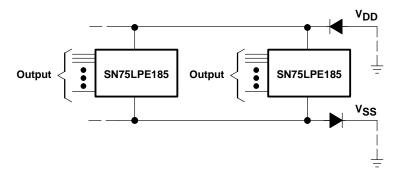


Figure 8. Power-Supply Protection to Meet Power-Off Fault Conditions of TIA/EIA-232-F

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APPLICATION INFORMATION

WAKE-UP mode

While in the WAKE-UP mode, all the drivers and receivers of the SN75LPE185 device are in the high-impedance state, except for receiver 5, which can be used as a ring indicator function. In this mode, the current drawn from the power supplies is low, to conserve power.

In today's PCs, board designers are becoming more concerned about power consumption. The flexibility of the SN75LPE185 during WAKE-UP mode allows the designer to operate the device at auxiliary power-supply voltages below specified levels. The SN75LPE185 functions properly during WAKE-UP mode, using the following power-supply conditions:

- (a) $V_{CC} = 4.75 \text{ V}$, $V_{DD} = 9 \text{ V}$, and $V_{SS} = -9 \text{ V}$ (data-sheet specifications)
- (b) $V_{CC} = 5 \text{ V}$, $V_{DD} = 5 \text{ V}$, and $V_{SS} = -5 \text{ V}$
- (c) $V_{CC} = 5 \text{ V}$, $V_{DD} = \text{open}$, and $V_{SS} = \text{open}$
- (d) $V_{CC} = 5 \text{ V}$, $V_{DD} = 5 \text{ V}$, and V_{SS} is shorted to the most negative supply.

Condition (a) describes the minimum supply voltages necessary for the device to comply fully to specifications.

Conditions (b) and (d) describe the condition where a –5-V supply is not available during auxiliary power. In this case, V_{SS} must be shorted to the most negative supply (i.e., GND or a voltage source close to, but below GND).

Condition (c) states V_{DD} and V_{SS} power supplies can be shut off.

In all cases, GND is understood to be 0 V, and the power-supply voltages should never exceed the absolute maximum ratings.





PACKAGE OPTION ADDENDUM

29-May-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN75LPE185NT	LIFEBUY	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	0 to 70	SN75LPE185NT	
SN75LPE185NTE4	LIFEBUY	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	0 to 70	SN75LPE185NT	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

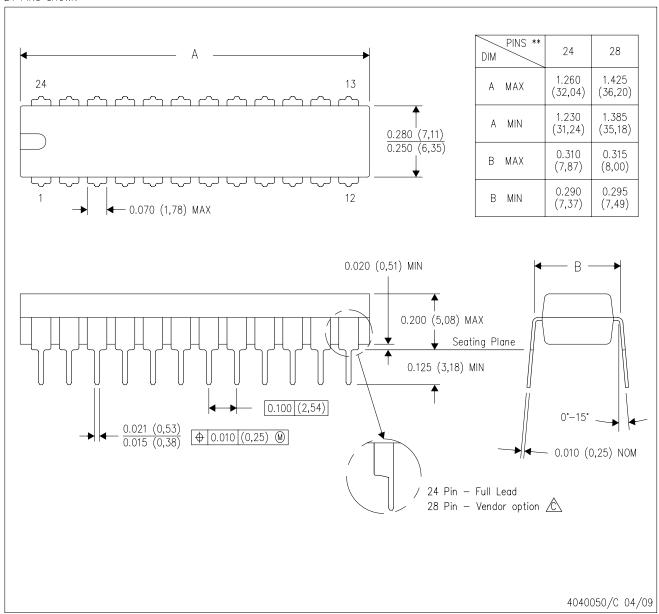
29-May-2015

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NT (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

The 28 pin end lead shoulder width is a vendor option, either half or full width.



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